

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/698,435 IMAGAWA ET AL.	
		Examiner	Art Unit	Page 1 of 1 CongVan Tran 2688

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,801,663 B2	10-2004	Matsushita et al.	382/236
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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